

# MOS FIELD EFFECT TRANSISTOR

2SK3433

# SWITCHING N-CHANNEL POWER MOS FET

### **DESCRIPTION**

The 2SK3433 is N-channel MOS Field Effect Transistor designed for high current switching applications.

#### **FEATURES**

• Super low on-state resistance:

 $R_{DS(on)1}$  = 26  $m\Omega$  MAX. (Vgs = 10 V, Ip = 20 A)

 $R_{DS(on)2} = 41 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.0 \text{ V, Ip} = 20 \text{ A)}$ 

- Low Ciss: Ciss = 1500 pF TYP.
- Built-in gate protection diode

#### ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3433	TO-220AB
2SK3433-S	TO-262
2SK3433-ZJ	TO-263
2SK3433-Z	TO-220SMD <sup>Note</sup>

**Note** TO-220SMD package is produced only in Japan.

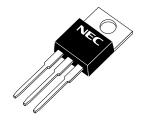
(TO-220AB)

### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	60	V
Gate to Source Voltage (Vps = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±40	Α
Drain Current (pulse) Note1	D(pulse)	±80	Α
Total Power Dissipation (Tc = 25°C)	Pτ	47	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	Pτ	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C
Single Avalanche Current Note2	las	21	Α
Single Avalanche Energy Note2	Eas	44	mJ

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%

2. Starting Tch = 25°C, VdD = 30 V, Rg = 25  $\Omega$ , Vgs = 20  $\rightarrow$  0 V



(TO-262)



(TO-263, TO-220SMD)



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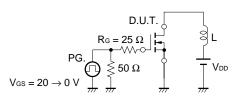
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

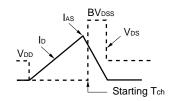


# **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

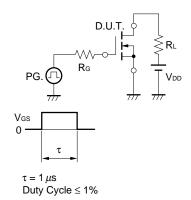
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	Vps = 60 V, Vgs = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	٧
Forward Transfer Admittance	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 20 A	11	22		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 20 A		22	26	mΩ
	RDS(on)2	Vgs = 4.0 V, ID = 20 A		29	41	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		1500		pF
Output Capacitance	Coss	V <sub>G</sub> S = 0 V		250		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		120		pF
Turn-on Delay Time	<b>t</b> d(on)	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 20 A		35		ns
Rise Time	tr	Vgs = 10 V		320		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 10 Ω		89		ns
Fall Time	tf			120		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = 48 V		30		nC
Gate to Source Charge	Qgs	Vgs = 10 V		5		nC
Gate to Drain Charge	Q <sub>GD</sub>	ID = 40 A		8		nC
Body Diode Forward Voltage	V <sub>F(S-D)</sub>	IF = 40 A, Vgs = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 40 A, Vgs = 0 V		44		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		60		nC

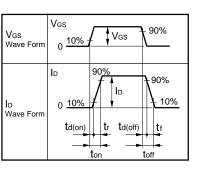
### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**





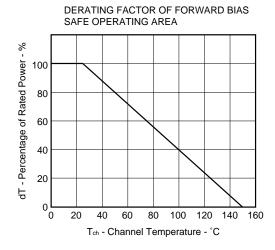
### TEST CIRCUIT 2 SWITCHING TIME

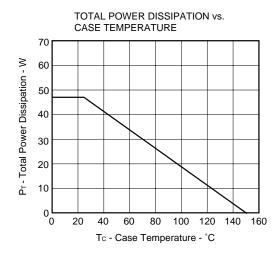




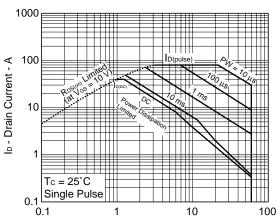
### **TEST CIRCUIT 3 GATE CHARGE**

### TYPICAL CHARACTERISTICS (TA = 25°C)



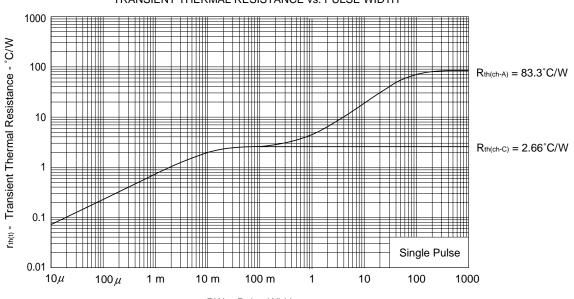


#### FORWARD BIAS SAFE OPERATING AREA



V<sub>DS</sub> - Drain to Source Voltage - V

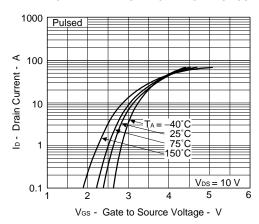
### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



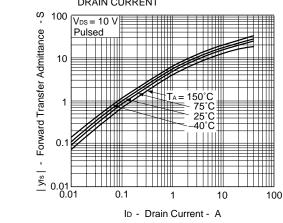
PW - Pulse Width - s

Data Sheet D14602EJ4V0DS 3

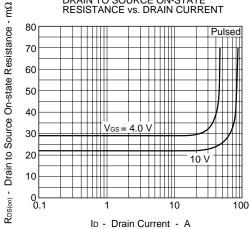
#### FORWARD TRANSFER CHARACTERISTICS



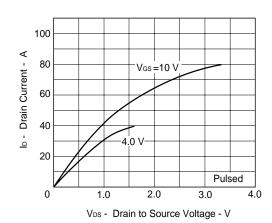
# FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



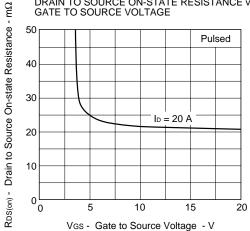
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



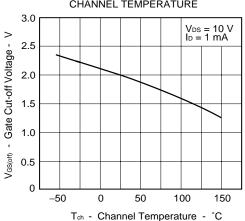
# DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

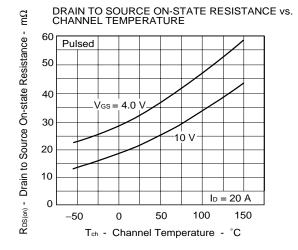


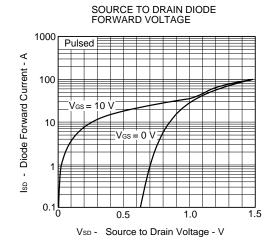
# DRAIN TO SOURCE ON-STATE RESISTANCE vs.

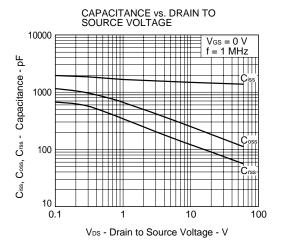


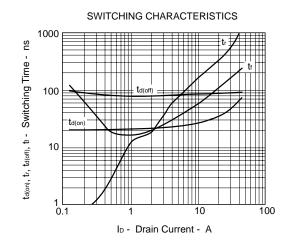
# GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

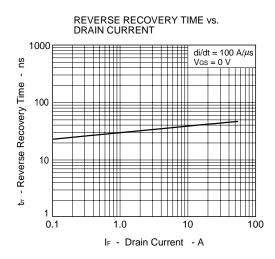


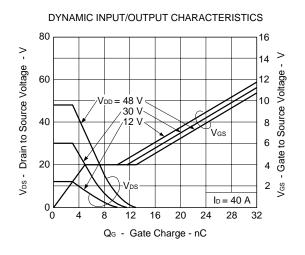




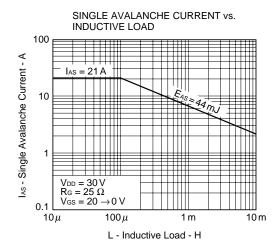


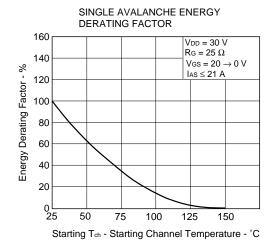






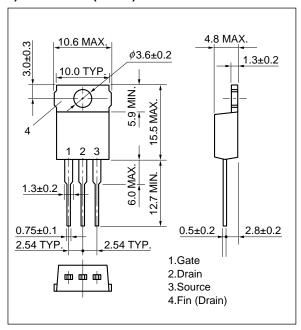
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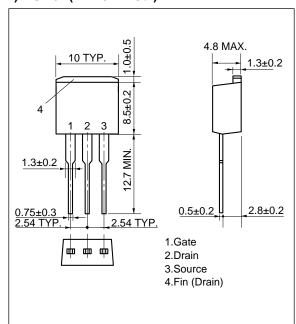


### **★ PACKAGE DRAWINGS (Unit: mm)**

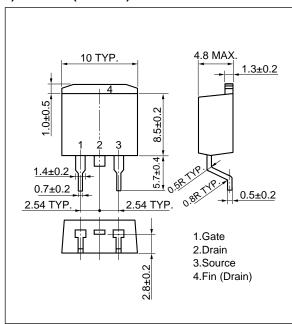
### 1) TO-220AB (MP-25)



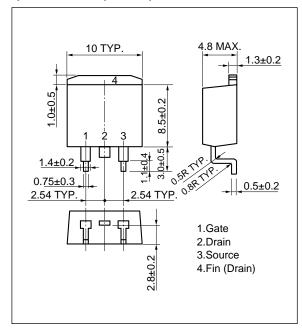
### 2) TO-262 (MP-25 Fin Cut)



### 3) TO-263 (MP-25ZJ)

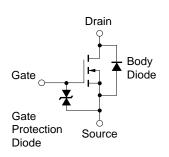


# 4) TO-220SMD (MP-25Z) Note



Note This Package is produced only in Japan.

### **EQUIVALENT CIRCUIT**



### Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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